

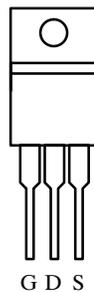
### N-Channel Enhancement-Mode MOSFETs, Logic Level

#### Product Summary

$V_{(BR)DSS}$ (V)	$r_{DS(on)}$ ( $\Omega$ )	$I_D$ (A)
60	0.022 @ $V_{GS} = 10$ V	40
	0.025 @ $V_{GS} = 4.5$ V	40

**175°C Rated**  
Maximum Junction Temperature  
**TrenchFET™**  
Power MOSFETs

TO-220AB

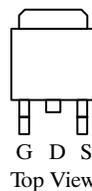


Top View

SUP40N06-25L

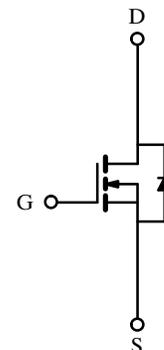
DRAIN connected to TAB

TO-263



Top View

SUB40N06-25L



N-Channel MOSFET

#### Absolute Maximum Ratings ( $T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current ( $T_J = 175^\circ\text{C}$ )	$I_D$	$T_C = 25^\circ\text{C}$	A
		$T_C = 100^\circ\text{C}$	
Pulsed Drain Current	$I_{DM}$	100	
Avalanche Current	$I_{AR}$	40	
Repetitive Avalanche Energy <sup>a</sup>	$E_{AR}$	$L = 0.1$ mH	mJ
Power Dissipation		$T_C = 25^\circ\text{C}$ (TO-220AB and TO-263)	
		$T_A = 25^\circ\text{C}$ (TO-263) <sup>c</sup>	3.7
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to 175	$^\circ\text{C}$

#### Thermal Resistance Ratings

Parameter	Symbol	Limit	Unit
Junction-to-Ambient	$R_{thJA}$	PCB Mount (TO-263) <sup>c</sup>	$^\circ\text{C}/\text{W}$
		Free Air (TO-220AB)	
Junction-to-Case	$R_{thJC}$	1.6	

Notes:

- Duty cycle  $\leq 1\%$ .
- See SOA curve for voltage derating.
- Surface Mounted on FR4 Board,  $t \leq 10$  sec.

This product is currently in development. Inquiries regarding the status of this product should be directed to Siliconix Marketing,

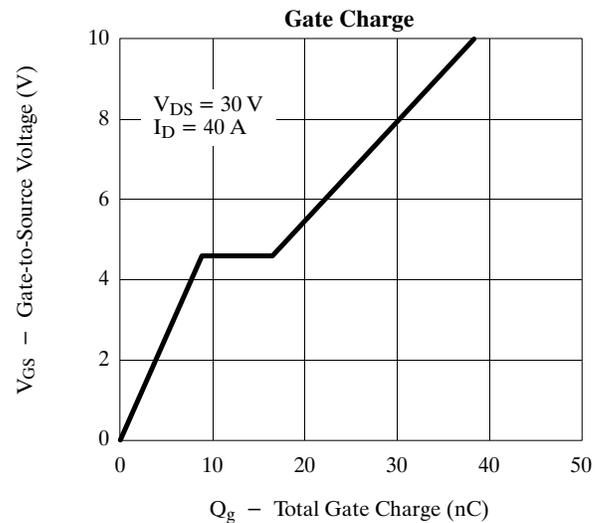
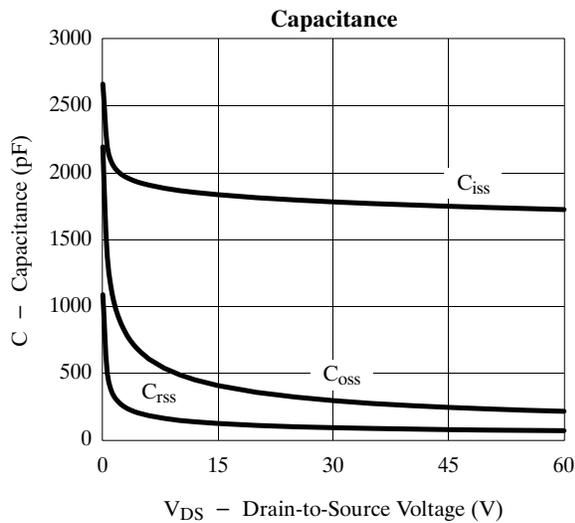
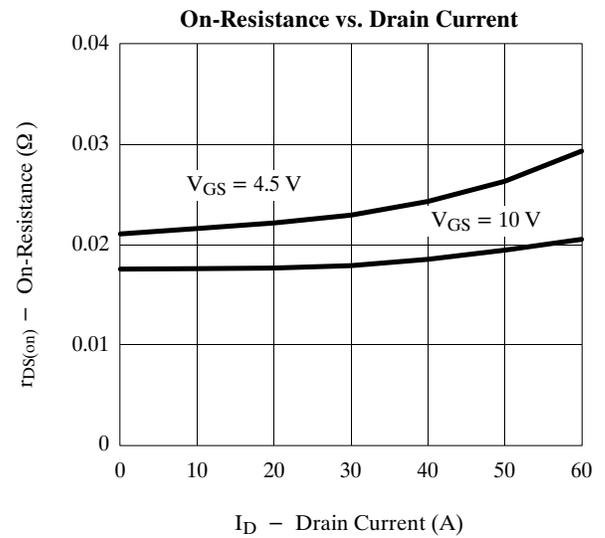
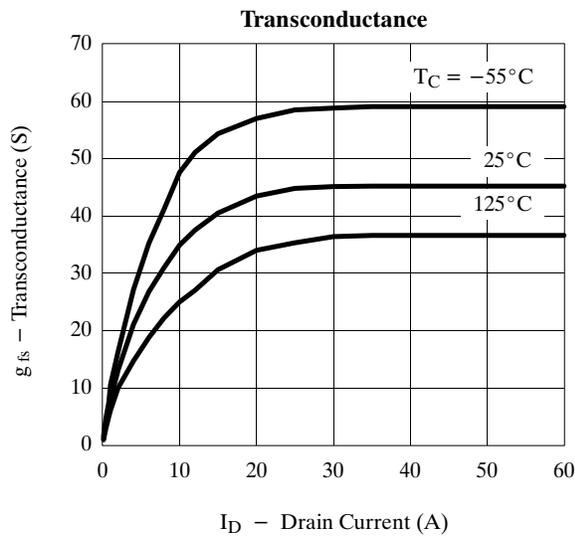
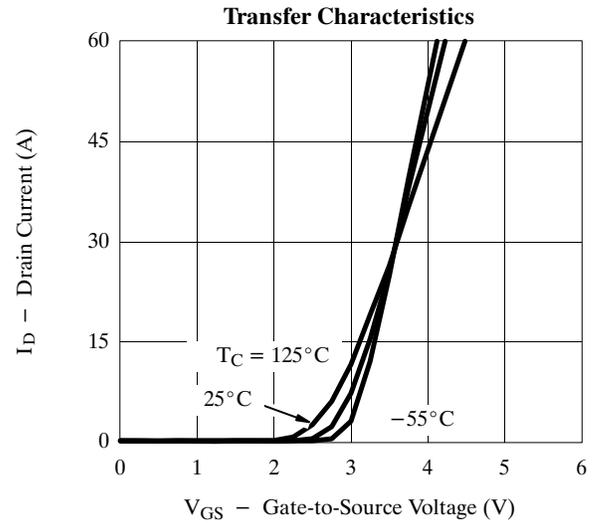
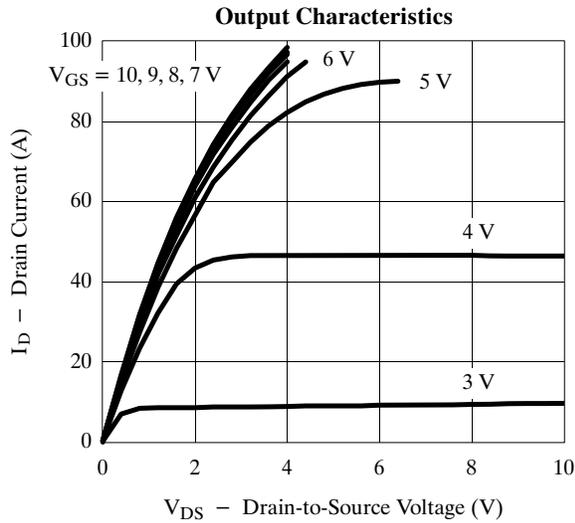
### Specifications ( $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{DS} = 250\ \mu\text{A}$	1.0	2.0	3.0	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$			1	$\mu\text{A}$
		$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C}$			50	
		$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}, T_J = 175^\circ\text{C}$			150	
On-State Drain Current <sup>b</sup>	$I_{D(on)}$	$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$	40			A
Drain-Source On-State Resistance <sup>b</sup>	$r_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 20\text{ A}$			0.022	$\Omega$
		$V_{GS} = 10\text{ V}, I_D = 20\text{ A}, T_J = 125^\circ\text{C}$			0.043	
		$V_{GS} = 10\text{ V}, I_D = 20\text{ A}, T_J = 175^\circ\text{C}$			0.053	
		$V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$			0.025	
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = 15\text{ V}, I_D = 20\text{ A}$				S
<b>Dynamic<sup>a</sup></b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$		1800		$\text{pF}$
Output Capacitance	$C_{oss}$			350		
Reverse Transfer Capacitance	$C_{rss}$			100		
Total Gate Charge <sup>c</sup>	$Q_g$	$V_{DS} = 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 40\text{ A}$		40	60	$\text{nC}$
Gate-Source Charge <sup>c</sup>	$Q_{gs}$			9		
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$			10		
Turn-On Delay Time <sup>c</sup>	$t_{d(on)}$	$V_{DD} = 30\text{ V}, R_L = 0.8\ \Omega$ $I_D = 40\text{ A}, V_{GEN} = 10\text{ V}, R_G = 2.5\ \Omega$		10	20	$\text{ns}$
Rise Time <sup>c</sup>	$t_r$			9	20	
Turn-Off Delay Time <sup>c</sup>	$t_{d(off)}$			28	50	
Fall Time <sup>c</sup>	$t_f$			7	15	
<b>Source-Drain Diode Ratings and Characteristics (<math>T_C = 25^\circ\text{C}</math>)<sup>a</sup></b>						
Continuous Current	$I_s$				40	A
Pulsed Current	$I_{SM}$				100	
Forward Voltage <sup>b</sup>	$V_{SD}$	$I_F = 40\text{ A}, V_{GS} = 0\text{ V}$		1.0	1.5	V
Reverse Recovery Time	$t_{rr}$	$I_F = 40\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$		48	100	ns
Peak Reverse Recovery Current	$I_{RM(REC)}$			6		A
Reverse Recovery Charge	$Q_{rr}$			0.15		$\mu\text{C}$

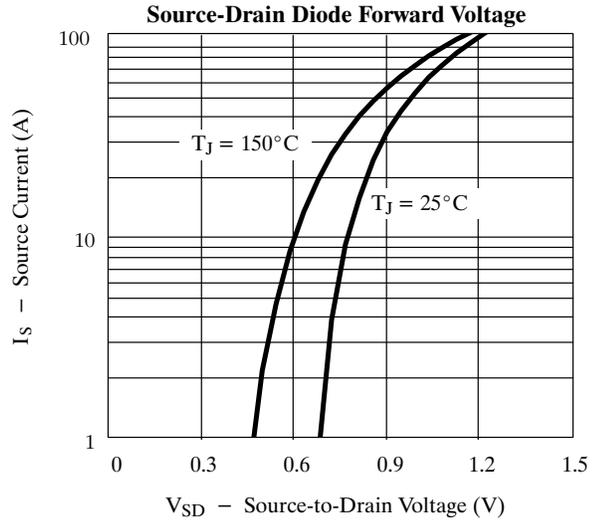
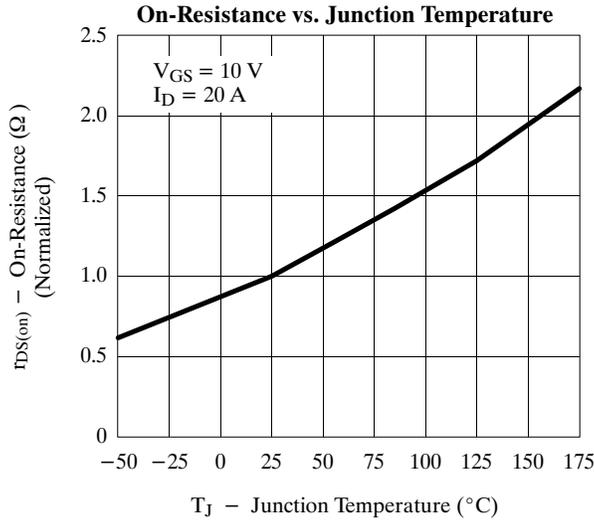
Notes:

- Guaranteed by design, not subject to production testing.
- Pulse test; pulse width  $\leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$ .
- Independent of operating temperature.

## Typical Characteristics (25°C Unless Otherwise Noted)



## Typical Characteristics (25°C Unless Otherwise Noted)



## Thermal Ratings

